Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/811,963	KAWAJI ET AL.	
Examiner	Art Unit	•
Patrick Miller	2837	

	SEAR	CHED	
Class	Subclass	Date	Examiner
318	801,811,7 29,438	2/24/2005	РМ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
PN detector; capacitor; reactor/coil/inductor; power factor; resonant frequency; dc bus	2/24/2005	РМ
<u>.</u>		